




SPECIFICATION SHEET

SPECIFICATION SHEET NO.	Q0618- 1206B471K631DC
DATE	June 18, 2023
REVISION	A2
DESCRIPTION	Multilayer Ceramic Chip Capacitors, Medium Voltage 1206 (3216 Metric) Series, L3.20mm*W1.60mm, Thickness: 1.35mm Max. Dielectric X7R, Capacitance 470pF, Tolerance ±10%, Rated Voltage 630V Operating Temp. Range -55°C ~+125°C Package in Tape/Reel, 3,000pcs/Reel RoHS/RoHS III compliant
CUSTOMER	
CUSTOMER PART NUMBER	
CROSS REF. PART NUMBER	
ORIGINAL PART NUMBER	Aillen 1206B471K631DC
PART CODE	1206B471K631DC

VENDOR APPROVE			
Issued/Checked/Approved			
DATE: June 18, 2023			

CUSTOMER APPROVE	
DATE:	
6/18/2023	

MULTILAYER CERAMIC CHIP CAPACITORS 1206 SERIES

MAIN FEATURE

MLCC consists of a conducting material and electrodes. To manufacture a chip-type SMT and achieve miniaturization, high density and high efficiency, ceramic condensers are used. MLCC is made by NP0, X7R, and Y5V dielectric material and which provides medium Voltage product with high electrical precision, stability and reliability.

MAIN FEATURE

- RoHS III Compliant • Wide Operating Temperature Range -55~+125°C • High capacitance and High Voltage in given case size • A wide selection of sizes is available (0603 to 1812) • Capacitor with lead-free termination (pure Tin)

APPLICATION

- DC to DC converter. • High voltage coupling/DC blocking • Back-lighting inverters • Snubbers in high frequency power convertors

RFQ

[Request For Quotation](#)

PART CODE GUIDE

Code	Name	Key Specification Option
1206	Size	0603 (1608): L1.60*W0.80mm; 0805 (2012): L2.00*W1.25mm 1206 (3216): L3.20*W1.60mm ; 1210 (3225): L3.20*W2.50mm 1812 (4532): L4.50*W3.20mm
B	Dielectric	N: NP0 (COG); B: X7R ; Y: Y5V
471	Capacitance	Two significant digits followed by number of Zero, The 3rd digit signifies the multiplying factor, and letter R is decimal point. 0R5: 0.5pF; 1R0:1.0pF; 104: 100nF; 471: 470pF
K	Tolerance	B=±0.1pF; C=±0.25pF; D=±0.5pF; F=±1%; G=±2%; J=±5%; K=±10% M=±20%; Z=-20/+80%
631	Rated Voltage	Two significant digits followed by No. of zeros. "R" is in place of decimal point. 201=200 VDC; 251=250 VDC; 501=500 VDC; 631 =630 VDC
D	Thickness	A: 0.60 ± 0.10mm; B: 0.85 ± 0.15mm; C: 0.95 ± 0.10mm; D: 1.25 ± 0.10mm I: 1.25 ± 0.20mm; G: 1.60 ± 0.20mm; K: 2.00 ± 0.20mm; M: 2.50 ± 0.30mm; N: 0.50+0.05mm; S: 0.80+0.10mm; U: 2.80 ± 0.30mm; X: 0.80 ± 0.20mm
C	Package	A: 1Kpcs/Reel; B: 2Kpcs/Reel; C: 3Kpcs/Reel ; D: 4Kpcs/Reel; I: 10Kpcs/Reel; K: 0.5 Kpcs/Reel; F: others
	Internal Control	Internal Code: Letter + Number; Blank: N/A;

MULTILAYER CERAMIC CHIP CAPACITORS 1206 SERIES

DIMENSION (Unit: mm)



Image for reference

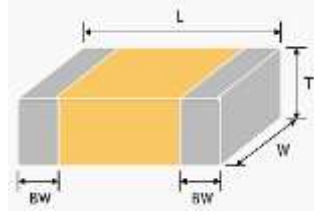


Table 1

Size Code	L	W	T	BW
0603 (1608)	1.60±0.15	0.80±0.15	0.95	0.20
0805 (2012)	2.00±0.20	1.25±0.20	1.45	0.30
1206 (3216)	3.20±0.20	1.60±0.20	1.80	0.30
	3.20+0.3/-0.1	1.60+0.3/-0.1	1.90	
1210 (3225)	3.20±0.40	2.50±0.30	2.80	0.30
1812 (4532)	4.50±0.40	3.20±0.30	2.80	0.26

MULTILAYER CERAMIC CHIP CAPACITORS 1206 SERIES
GENERAL ELECTRONICAL CHARACTERISTICS
Table 2

Dielectric	NPO (COG)	X7R	Y5V
Size	0603, 0805, 1206, 1210, 1812		0805, 1206, 1210, 1812
Capacitance range*	0.5pF to 39.0nF	100pF to 1.0μF	10nF to 1.0μF
Capacitance Tolerance	Cap≤5pF: B (±0.1pF), C (±0.25pF) 5pF<Cap<10pF: C (±0.25pF), D (±0.5pF) Cap≥10pF: F (±1%), G (±2%), J (±5%), K (±10%)	J (±5%), K (±10%), M (±20%)	Z (-20/+80%)
Rated Voltage	200V, 250V, 500V, 630V		200V, 250V
Tan δ*	Cap<30pF: Q≥400+20C Cap≥30pF: Q≥1000	≤2.5% (Apply 1.0±0.2Vrms, 1.0KHz±10%)	≤5%
Insulation resistance at Ur**	≥100GΩ or R•C≥1000 whichever is smaller	≥10GΩ or R•C≥100Ω-F whichever is smaller	
Operating Temperature	-55 ~+125°C		-25 ~+85°C
Capacitance Characteristic	±30ppm/°C	±15%	+30/-80%
Termination	Cu (or Ag)/Ni/Sn (lead-free termination)		

Note:

- 1) * Measured at the condition of 30~70% related humidity.
- 2) NPO: Apply 1.0±0.2Vrms, 1.0MHz±10% for Cap≤1000pF and 1.0±0.2Vrms, 1.0kHz±10% for Cap>1000pF, 25°C at ambient temperature.
- 3) X7R: Apply 1.0±0.2Vrms, 1.0kHz±10%, at 25°C ambient temperature.
- 4) Y5V: Apply 1.0±0.2Vrms, 1.0kHz±10%, at 20°C ambient temperature.
- 5) ** Measured at 500VDC for 60 sec, for UR>500VDC

MULTILAYER CERAMIC CHIP CAPACITORS 1206 SERIES

CAPACITANCE RANGE - NPO DIELECTRIC 0603, 0805, 1206 SIZES

Table 3-A

Size	0603		0805				1206				
	VDC (V)	200	250	200	250	500	630	200	250	500	630
0.5pF (0R5)	S	S	A	A	A	A					
1.0pF (1R0)	S	S	A	A	A	A					
1.2pF (1R2)	S	S	A	A	A	A					
1.5pF (1R5)	S	S	A	A	A	A	B	B	B	B	
1.8pF (1R8)	S	S	A	A	A	A	B	B	B	B	
2.2pF (2R2)	S	S	A	A	A	A	B	B	B	B	
2.7pF (2R7)	S	S	A	A	A	A	B	B	B	B	
3.3pF (3R3)	S	S	A	A	A	A	B	B	B	B	
3.9pF (3R9)	S	S	A	A	A	A	B	B	B	B	
4.7pF (4R7)	S	S	A	A	A	A	B	B	B	B	
5.6pF (5R6)	S	S	A	A	A	A	B	B	B	B	
6.8pF (6R8)	S	S	A	A	A	A	B	B	B	B	
8.2pF (8R2)	S	S	A	A	A	A	B	B	B	B	
10pF (100)	S	S	A	A	A	A	B	B	B	B	
12pF (120)	S	S	A	A	A	A	B	B	B	B	
15pF (150)	S	S	A	A	A	A	B	B	B	B	
18pF (180)	S	S	A	A	A	A	B	B	B	B	
20pF (200)	S	S	A	A	A	A	B	B	B	B	
22pF (220)	S	S	A	A	A	A	B	B	B	B	
27pF (270)	S	S	A	A	A	A	B	B	B	B	
30pF (300)	S	S	A	A	A	A	B	B	B	B	
33pF (330)	S	S	A	A	A	A	B	B	B	B	
39pF (390)	S	S	A	A	A	A	B	B	B	B	
47pF (470)	S	S	A	A	A	A	B	B	B	B	
56pF (560)	S	S	A	A	A	A	B	B	B	B	
68pF (680)	S	S	A	A	A	A	B	B	B	B	
82pF (820)	S	S	A	A	A	A	B	B	B	B	
100pF (101)	S	S	A	A	A	A	B	B	B	B	
120pF (121)	S	S	A	B	D	D	B	B	B	B	
150pF (151)	S	S	B	D	D	D	B	B	B	B	

MULTILAYER CERAMIC CHIP CAPACITORS 1206 SERIES
CAPACITANCE RANGE - NP0 DIELECTRIC 0603, 0805, 1206 SIZES
Table 3-B

Size	0603		0805				1206				
	VDC (V)	200	250	200	250	500	630	200	250	500	630
180pF (181)	S	S	B	D	D	D	D	B	B	B	B
220pF (221)	S	S	D	D	D	D	D	B	B	B	B
270pF (271)	X	X	D	D	D	D	D	B	C	C	C
330pF (331)	X	X	D	D	D	D	D	B	C	C	C
390pF (391)	X	X	D	D	D	D	D	B	C	C	C
470pF (471)	X	X	D	D	I	I	I	C	C	C	C
560pF (561)	X	X	D	D	I	I	I	C	C	C	C
680pF (681)			D	D	I	I	I	C	D	D	D
820pF (821)			D	D	I	I	I	C	D	D	D
1,000pF (102)			D	D	I	I	I	C	G	G	G
1,200pF (122)			D	D				C	G	G	G
1,500pF (152)			D	D				D	G	G	G
1,800pF (182)			D	D				D	G	G	G
2,200pF (222)			D	D				D	G	G	G
2,700pF (272)								D	G		
3,300pF (332)								D	G		
3,900pF (392)								D	G		
4,700pF (472)								D	G		

CAPACITANCE RANGE - NP0 DIELECTRIC 1210, 1812SIZES
Table 3-C

Size	1210				1812				
	VDC (V)	200	250	500	630	200	250	500	630
10pF (100)	C	C	C	C	C	D	D	D	D
12pF (120)	C	C	C	C	C	D	D	D	D
15pF (150)	C	C	C	C	C	D	D	D	D
18pF (180)	C	C	C	C	C	D	D	D	D
20pF (200)	C	C	C	C	C	D	D	D	D
22pF (220)	C	C	C	C	C	D	D	D	D
27pF (270)	C	C	C	C	C	D	D	D	D
33pF (330)	C	C	C	C	C	D	D	D	D

MULTILAYER CERAMIC CHIP CAPACITORS 1206 SERIES

CAPACITANCE RANGE - NPO DIELECTRIC 1210. 1812SIZES

Table 3-D

Size	1210				1812			
	200	250	500	630	200	250	500	630
VDC (V)	200	250	500	630	200	250	500	630
39pF (390)	C	C	C	C	D	D	D	D
47pF (470)	C	C	C	C	D	D	D	D
56pF (560)	C	C	C	C	D	D	D	D
68pF (680)	C	C	C	C	D	D	D	D
82pF (820)	C	C	C	C	D	D	D	D
100pF (101)	C	C	C	C	D	D	D	D
120pF (121)	C	C	C	C	D	D	D	D
150pF (151)	C	C	C	C	D	D	D	D
180pF (181)	C	C	C	C	D	D	D	D
220pF (221)	C	C	C	C	D	D	D	D
270pF (271)	C	C	C	C	D	D	D	D
330pF (331)	C	C	C	C	D	D	D	D
390pF (391)	C	C	C	C	D	D	D	D
470pF (471)	C	C	C	C	D	D	D	D
560pF (561)	C	C	C	C	D	D	D	D
680pF (681)	C	C	C	C	D	D	D	D
820pF (821)	C	C	C	C	D	D	D	D
1,000pF (102)	D	D	D	D	D	D	D	D
1,200pF (122)	D	D	D	D	D	D	D	D
1,500pF (152)	D	D	D	D	D	D	D	D
1,800pF (182)	D	D	D	D	D	D	D	D
2,200pF (222)	D	D	D	D	D	D	D	D
2,700pF (272)	D	D	D	D	D	D	D	D
3,300pF (332)	D	D	D	D	D	D	D	D
3,900pF (392)	D	D	D	D	D	D	D	D
4,700pF (472)	G	G			D	D	D	D
5,600pF (562)	G	G			D	D	D	D
6,800pF (682)	G	G			D	D	D	D
8,200pF (822)	G	G					D	D

MULTILAYER CERAMIC CHIP CAPACITORS 1206 SERIES

CAPACITANCE RANGE - NP0 DIELECTRIC 1210, 1812SIZES

Table 3-E

Size	1210				1812			
VDC (V)	200	250	500	630	200	250	500	630
0.010µF (103)	G	G					D	D
0.022µF (223)	M	M					K	K
0.033µF (333)	M	M					M	M

CAPACITANCE RANGE – X7R DIELECTRIC 0603, 0805 1206 SIZES

Table 4-A

Size	0603		0805				1206			
VDC (V)	200	250	200	250	500	630	200	250	500	630
100pF (101)	X	X	B	B	B	B	D	D	D	D
120pF (121)	X	X	B	B	B	B	D	D	D	D
150pF (151)	X	X	B	B	B	B	D	D	D	D
180pF (181)	X	X	B	B	B	B	D	D	D	D
220pF (221)	X	X	B	B	B	B	D	D	D	D
270pF (271)	X	X	B	B	B	B	D	D	D	D
330pF (331)	X	X	B	B	B	B	D	D	D	D
390pF (391)	X	X	B	B	B	B	D	D	D	D
470pF (471)	X	X	B	B	B	B	D	D	D	D
560pF (561)	X	X	B	B	B	B	D	D	D	D
680pF (681)	X	X	B	B	B	B	D	D	D	D
820pF (821)	X	X	B	B	B	B	D	D	D	D
1,000pF (102)	X	X	B	B	B	B	D	D	D	D
1,200pF (122)	X	X	B	B	B	B	D	D	D	D
1,500pF (152)	X	X	B	B	B	B	D	D	D	D
1,800pF (182)	X	X	B	B	B	B	D	D	D	D
2,200pF (222)	X	X	B	B	B	B	D	D	D	D
2,700pF (272)	X	X	B	B	B	B	D	D	D	D
3,300pF (332)	X	X	B	B	B	B	D	D	D	D
3,900pF (392)	X	X	B	B	B	B	D	D	D	D
4,700pF (472)	X	X	B	B	D	D	D	D	D	D
5,600pF (562)	X	X	D	D	D	D	D	D	D	D

MULTILAYER CERAMIC CHIP CAPACITORS 1206 SERIES
CAPACITANCE RANGE – X7R DIELECTRIC 0603, 0805 1206 SIZES
Table 4-B

Size	0603		0805				1206				
	VDC (V)	200	250	200	250	500	630	200	250	500	630
6,800pF (682)	X	X	D	D	D	D	D	D	D	D	D
8,200pF (822)	X	X	D	D	D	D	D	D	D	D	D
0.010μF (103)	X	X	D	D	D	D	D	D	B/D	D	D
0.012μF (123)			D	D	D	D	D	D	D	D	D
0.015μF (153)			D	D	D	D	D	D	D	D	D
0.018μF (183)			D	D	D	D	D	D	D	D	D
0.022μF (223)			D	D	D	D	D	D	D	G	G
0.027μF (273)			D	D			D	D	D	G	G
0.033μF (333)			D	D			G	G	G	G	G
0.039μF (393)			D	D			G	G	G	G	G
0.047μF (473)			D	D			G	G	G	G	G
0.056μF (563)			D	D			G	G	G	G	G

CAPACITANCE RANGE – X7R DIELECTRIC 0805 1206 SIZES
Table 4-C

Size	0805		1206						
	VDC (V)	200	250	200	250	400	450	500	630
0.068μF (683)	D	D	G	G	G	G			
0.082μF (823)	D		G	G	G	G			
0.10μF (104)	D		G	G	G	G			
0.12μF (124)			G	G					
0.15μF (154)			G	G					
0.18μF (184)			G	G					
0.22μF (224)			G	G					

CAPACITANCE RANGE – X7R DIELECTRIC 1210, 1812 SIZES
Table 4-D

Size	1210				1812				
	VDC (V)	200	250	500	630	200	250	500	630
100pF (101)	D	D	D	D					
120pF (121)	D	D	D	D					
150pF (151)	D	D	D	D					

MULTILAYER CERAMIC CHIP CAPACITORS 1206 SERIES

CAPACITANCE RANGE – X7R DIELECTRIC 1210, 1812 SIZES

Table 4-E

Size	1210				1812			
	200	250	500	630	200	250	500	630
180pF (181)	D	D	D	D				
220pF (221)	D	D	D	D				
270pF (271)	D	D	D	D				
330pF (331)	D	D	D	D				
390pF (391)	D	D	D	D				
470pF (471)	D	D	D	D				
560pF (561)	D	D	D	D				
680pF (681)	C	C	D	D				
820pF (821)	C	C	D	D				
1,000pF (102)	C	C	D	D	D	D	D	D
1,200pF (122)	C	C	D	D	D	D	D	D
1,500pF (152)	C	C	D	D	D	D	D	D
1,800pF (182)	C	C	D	D	D	D	D	D
2,200pF (222)	C	C	D	D	D	D	D	D
2,700pF (272)	C	C	D	D	D	D	D	D
3,300pF (332)	C	C	D	D	D	D	D	D
3,900pF (392)	C	C	D	D	D	D	D	D
4,700pF (472)	C	C	D	D	D	D	D	D
5,600pF (562)	C	C	D	D	D	D	D	D
6,800pF (682)	C	C	D	D	D	D	D	D
8,200pF (822)	C	C	D	D	D	D	D	D
0.010μF (103)	C	C	D	D	D	D	D	D
0.012μF (123)	C	C	D	D	D	D	D	D
0.015μF (153)	C	C	D	D	D	D	D	D
0.018μF (183)	C	C	D	D	D	D	D	D
0.022μF (223)	C	C	D	D	D	D	D	D
0.027μF (273)	C	C	G	G	D	D	D	D
0.033μF (333)	C	C	G	G	D	D	D	D
0.039μF (393)	C	C	G	G	D	D	D	D

MULTILAYER CERAMIC CHIP CAPACITORS 1206 SERIES

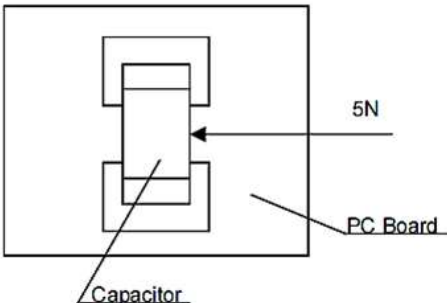
CAPACITANCE RANGE – X7R DIELECTRIC 1210, 1812 SIZES

Table 4-F

Size	1210						1812			
	VDC (V)	200	250	400	450	500	630	200	250	500
0.047µF (473)	D	D			G	G	D	D	D	D
0.056µF (563)	D	D			G	G	D	D	K	K
0.068µF (683)	D	D			K	K	D	D	K	K
0.082µF (823)	D	D			K	K	D	D	K	K
0.010µF (103)	C	C			D	D	D	D	D	D
0.012µF (123)	C	C			D	D	D	D	D	D
0.015µF (153)	C	C			D	D	D	D	D	D
0.018µF (183)	C	C			D	D	D	D	D	D
0.022µF (223)	C	C			D	D	D	D	D	D
0.027µF (273)	C	C			G	G	D	D	D	D
0.033µF (333)	C	C			G	G	D	D	D	D
0.039µF (393)	C	C			G	G	D	D	D	D
0.047µF (473)	D	D			K	K	D	D	D	D
0.056µF (563)	D	D			G	G	D	D	K	K
0.068µF (683)	G	G			K	K	D	D	K	K
0.082µF (823)	G	G			K	K	D	D	K	K
0.10µF (104)	G	G			K	K	D	D	K	K
0.12µF (124)	G	G	M	M	M	M	D	D	M	M
0.15µF (154)	M	M	M	M	M	M	K	K	M	M
0.18µF (184)	M	M	M	M			K	K	M	M
0.22µF (224)	M	M	M	M			K	K	M	M
0.27µF (274)	M	M	M	M			K	K	M	
0.33µF (334)	M	M	M	M			K	K	M	
0.39µF (394)	M	M					K	K	M	
0.47µF (474)	M	M					K	K	M	
0.56µF (564)	M	M					M	M		
0.68µF (684)	M	M					M	M		
0.84µF (844)							M	M		
1.0µF (105)							M	M		

MULTILAYER CERAMIC CHIP CAPACITORS 1206 SERIES

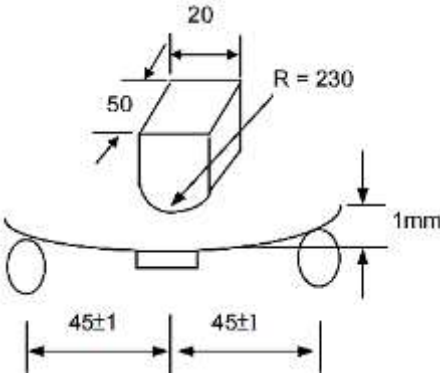
RELIABILITY TEST CONDITIONS AND REQUIREMENTS

Item	Test Condition	Requirements																
Visual and Mechanical	-	<ul style="list-style-type: none"> * No remarkable defect. * Dimensions to conform to individual spec. sheet. 																
Capacitance	Class I: COG (NP0) $\leq 1000\text{pF}$, $1.0 \pm 0.2V_{rms}$, $1\text{MHz} \pm 10\%$	* Shall not exceed the limits given in the detailed spec.																
Q/D.F (Dissipation Factor)	$> 1000\text{pF}$, $1.0 \pm 0.2V_{rms}$, $1\text{KHz} \pm 10\%$ Class II: (X7R, Y5V) $1.0 \pm 0.2V_{rms}$, $1\text{KHz} \pm 10\%$	NP0: $Cap \geq 30\text{pF}$, $Q \geq 1000$; $Cap < 30\text{pF}$, $Q \geq 400 + 20C$ X7R: $\leq 2.5\%$; Y5V: $\leq 5.0\%$																
Dielectric Strength	* To apply voltage: $100V = 2.5$ times of U_R ; $200V/250V = 2$ times of U_R $500V/630V = 1.5$ times of U_R ; * Duration: 1 to 5 sec.	* No evidence of damage or flash over during test.																
Insulation Resistance	$U_R = 100V$: To apply voltage at U_R for max. 120 sec. $U_R > 100V$: To apply voltage at U_R (500V max.) for 60 sec.	$\geq 10G\Omega$ or $R_{xC} \geq 100\Omega \cdot F$ whichever is smaller.																
Temperature Coefficient	With no electrical load @ Operating Temp. Range <table border="1" style="margin-left: auto; margin-right: auto;"> <thead> <tr> <th>T.C</th> <th>Temp. (°C)</th> </tr> </thead> <tbody> <tr> <td>NP0(COG)</td> <td>-55~125 at 25</td> </tr> <tr> <td>X7R</td> <td>-55~125 at 25</td> </tr> <tr> <td>Y5V</td> <td>-25~ 85 at 25</td> </tr> </tbody> </table>	T.C	Temp. (°C)	NP0(COG)	-55~125 at 25	X7R	-55~125 at 25	Y5V	-25~ 85 at 25	<table border="1" style="margin-left: auto; margin-right: auto;"> <thead> <tr> <th>T.C</th> <th>Capacitance Change</th> </tr> </thead> <tbody> <tr> <td>NP0 (COG)</td> <td>Within $\pm 30\text{ppm}/^\circ\text{C}$</td> </tr> <tr> <td>X7R</td> <td>Within $\pm 15\%$</td> </tr> <tr> <td>Y5V</td> <td>Within $+30\%/-80\%$</td> </tr> </tbody> </table>	T.C	Capacitance Change	NP0 (COG)	Within $\pm 30\text{ppm}/^\circ\text{C}$	X7R	Within $\pm 15\%$	Y5V	Within $+30\%/-80\%$
T.C	Temp. (°C)																	
NP0(COG)	-55~125 at 25																	
X7R	-55~125 at 25																	
Y5V	-25~ 85 at 25																	
T.C	Capacitance Change																	
NP0 (COG)	Within $\pm 30\text{ppm}/^\circ\text{C}$																	
X7R	Within $\pm 15\%$																	
Y5V	Within $+30\%/-80\%$																	
Adhesive Strength of Termination	* Capacitors mounted on a substrate. A force of 5N (≤ 0603) or 10N (> 0603) applied perpendicular to the place of substrate and parallel the line joining the center of terminations for 10 ± 1 second. 	* No remarkable damage or removal of the terminations.																

6/18/2023

MULTILAYER CERAMIC CHIP CAPACITORS 1206 SERIES

RELIABILITY TEST CONDITIONS AND REQUIREMENTS

Item	Test Condition	Requirements
Vibration Resistance	Vibration frequency: 10~55 Hz/min. * Total amplitude: 1.5mm * Test time: 6 hrs. (Two hrs each in three mutually perpendicular directions.)	* No remarkable damage. * Cap change and Q/D.F.: To meet initial spec.
Resistance to Flexure of Substrate	* The middle part of substrate shall be pressurized by means of the pressurizing rod at a rate of about 1mm per second until the deflection becomes 1mm. 	* No remarkable damage. * Cap change: COG(NPO): within $\pm 5.0\%$ or $\pm 0.5\text{pF}$ whichever is larger. X7R: within $\pm 12.5\%$ Y5V: within $\pm 30\%$ (This capacitance change means the change of capacitance under specified flexure of substrate from the capacitance measured before the test.)
Resistance to Soldering Heat	* Solder temperature: $260 \pm 5^\circ \text{C}$ * Dipping time: $10 \pm 1 \text{ sec}$ * Preheating: $120 \text{ to } 150^\circ \text{C}$ for 1 minute before immerse the capacitor in a eutectic solder. * Before initial measurement (Class II only): To apply de-aging at 150°C for 1hr then set for $24 \pm 2 \text{ hrs}$ at room temp. * Measurement to be made after de-aging at 150°C for 1hr then set for $24 \pm 2 \text{ hrs}$ at room	* No remarkable damage. * Cap change: NPO: within $\pm 2.5\%$ or 0.25pF whichever is larger X7R: within $\pm 7.5\%$; Y5V: within $\pm 20\%$ * Q/D.F, COG(NPO) / X7R / Y5V : $\leq 1.0 \times$ initial requirements. * 25% max. leaching on each edge.

MULTILAYER CERAMIC CHIP CAPACITORS 1206 SERIES
RELIABILITY TEST CONDITIONS AND REQUIREMENTS

Item	Test Condition	Requirements															
Resistance to Soldering Heat	<ul style="list-style-type: none"> * Solder temperature: $260 \pm 5^{\circ} \text{C}$ * Dipping time: 10 ± 1 sec * Preheating: 120 to 150°C for 1 minute before immerse the capacitor in a eutectic solder. * Before initial measurement (Class II only): To apply de-aging at 150°C for 1hr then set for 24 ± 2 hrs at room temp. * Measurement to be made after de-aging at 150°C for 1hr then set for 24 ± 2 hrs at room 	<ul style="list-style-type: none"> * No remarkable damage. * Cap change: NPO: within $\pm 2.5\%$ or 0.25pF whichever is larger X7R: within $\pm 7.5\%$; Y5V: within $\pm 20\%$ * Q/D.F., $\text{COG(NPO) / X7R / Y5V} : \leq 1.0 \times$ initial requirements. * 25% max. leaching on each edge. 															
Temperature Cycle	<p>*Conduct the five cycles according to the temperatures and time.</p> <table border="1" data-bbox="337 1052 936 1363"> <thead> <tr> <th>Step</th> <th>Temp. ($^{\circ}\text{C}$)</th> <th>Time(min)</th> </tr> </thead> <tbody> <tr> <td>1</td> <td>Min. operating temp.+0/-3</td> <td>30 ± 3</td> </tr> <tr> <td>2</td> <td>Room temp.</td> <td>2~3</td> </tr> <tr> <td>3</td> <td>Max. operating temp.+3/-0</td> <td>30 ± 3</td> </tr> <tr> <td>4</td> <td>Room temp.</td> <td>2~3</td> </tr> </tbody> </table> <ul style="list-style-type: none"> * Before initial measurement (Class II only): Perform $150+0/-10^{\circ} \text{C}$ for 1 hr and then set for 48 ± 4 hrs at room temp. * Measurement to be made after keeping at room temp. for 24 ± 2 hrs (Class I) or 48 ± 4 hrs (Class II). 	Step	Temp. ($^{\circ}\text{C}$)	Time(min)	1	Min. operating temp.+0/-3	30 ± 3	2	Room temp.	2~3	3	Max. operating temp.+3/-0	30 ± 3	4	Room temp.	2~3	<ul style="list-style-type: none"> * No remarkable damage. * Cap change: NPO: within $\pm 2.5\%$ or 0.25pF whichever is larger X7R: within $\pm 7.5\%$ Y5V: within $\pm 20\%$ * Q/D.F., $\text{COG(NPO) / X7R / Y5V} : \leq 1.0 \times$ Initial requirement * I.R. $\geq 0.25 \times$ initial requirements.
Step	Temp. ($^{\circ}\text{C}$)	Time(min)															
1	Min. operating temp.+0/-3	30 ± 3															
2	Room temp.	2~3															
3	Max. operating temp.+3/-0	30 ± 3															
4	Room temp.	2~3															
Solder ability	<ul style="list-style-type: none"> * Solder temperature: $235 \pm 5^{\circ} \text{C}$ * Dipping time: 2 ± 0.5 sec. 	95% min. coverage of all metalized area															

MULTILAYER CERAMIC CHIP CAPACITORS 1206 SERIES
RELIABILITY TEST CONDITIONS AND REQUIREMENTS

Item	Test Condition	Requirements																
High Temperature Load (Endurance)	<p>Test temp.:</p> <p>COG(NPO), X7R: $125 \pm 3^\circ \text{C}$; Y5V: $85 \pm 3^\circ \text{C}$</p> <p>* To apply voltage:</p> <p>(1) $U_R \leq 250\text{V}$: 200% of rated voltage.</p> <p>Exception item</p> <table border="1" data-bbox="344 660 912 971"> <thead> <tr> <th>UR</th> <th>Size</th> <th>Cap</th> <th>Voltage</th> </tr> </thead> <tbody> <tr> <td rowspan="2">100V</td> <td>0805</td> <td>≥ 124</td> <td rowspan="2">1.5 times of UR</td> </tr> <tr> <td>1206/1210</td> <td>≥ 105</td> </tr> <tr> <td rowspan="2">200V and 250V</td> <td>1210</td> <td>> 224</td> <td rowspan="2"></td> </tr> <tr> <td>1812</td> <td>> 474</td> </tr> </tbody> </table> <p>(2) $250 < U_R \leq 500\text{V}$: 150% of rated voltage.</p> <p>(3) $U_R > 500\text{V}$: 120% of rated voltage.</p> <p>(4) 1206,NP0 $\geq 1.5\text{pF}$: 100% of rated voltage.</p> <p>* Test temp.: $40 \pm 2^\circ \text{C}$</p> <p>* Humidity: 90~95% RH</p> <p>* Test time: 1000+24/-0 hrs.</p> <p>* Measurement to be made after keeping at room temp. for 24 ± 2 hrs (Class I) or 48 ± 4 hrs (Class II).</p>	UR	Size	Cap	Voltage	100V	0805	≥ 124	1.5 times of UR	1206/1210	≥ 105	200V and 250V	1210	> 224		1812	> 474	<p>* No remarkable damage.</p> <p>* Cap change:</p> <p>COG(NPO) : within $\pm 3\%$ or $\pm 0.3\text{pF}$ whichever is larger</p> <p>X7R : within $\pm 12.5\%$</p> <p>Y5V : within $\pm 30\%$</p> <p>* Q/D.F Value:</p> <p>COG(NPO): $\text{Cap} \geq 30\text{pF} : Q \geq 350$; $10\text{pF} \leq \text{Cap} < 30\text{pF} : Q \geq 275 + 2.5C$; $\text{Cap} < 10\text{pF} : Q \geq 200 + 10C$</p> <p>X7R: $\leq 3.0\%$</p> <p>Y5V: $\leq 7.5\%$</p> <ul style="list-style-type: none"> I.R.: $\geq 1\text{G}\Omega$ or $R_x C \geq 50\Omega \cdot \text{F}$ whichever is smaller.
UR	Size	Cap	Voltage															
100V	0805	≥ 124	1.5 times of UR															
	1206/1210	≥ 105																
200V and 250V	1210	> 224																
	1812	> 474																
Resistance to Soldering Heat	<p>* Solder temperature: $260 \pm 5^\circ \text{C}$</p> <p>* Dipping time: 10 ± 1 sec</p> <p>* Preheating: 120 to 150°C for 1 minute before immerse the capacitor in a eutectic solder.</p> <p>* Before initial measurement (Class II only): To apply de-aging at 150°C for 1hr then set for 24 ± 2 hrs at room temp.</p> <p>* Measurement to be made after de-aging at 150°C for 1hr then set for 24 ± 2 hrs at room</p>	<p>* No remarkable damage.</p> <p>* Cap change:</p> <p>NP0: within $\pm 2.5\%$ or 0.25pF whichever is larger</p> <p>X7R: within $\pm 7.5\%$;</p> <p>Y5V: within $\pm 20\%$</p> <p>* Q/D.F,</p> <p>COG(NPO) / X7R / Y5V : $\leq 1.0 \times$ initial requirements.</p> <p>* 25% max. leaching on each edge.</p>																

MULTILAYER CERAMIC CHIP CAPACITORS 1206 SERIES

RECOMMENDED PROFILE CONDITIONS

PREHEAT:

In order to minimize the risk of thermal shock during soldering, a carefully controlled preheat is required. The rate of preheat should not exceed 4°C per second and the final preheat temperature should be within 100°C of the soldering temperature for small chips such as 0603, 0805 and 1206, within 50°C of the soldering temperature for bigger chips such as 1210 and 1812, etc

SOLDERING

- (1) Use midly activated rosin RA and RMA fluxes do not use activated flux. The amount of solder in each solder joint should be controlled to prevent the damage of chip capacitors caused by the stress between solder, chips, and substrate.
- (2) Hand soldering with temperature-controlled iron not exceeding 30 watts and diameter of tip less than 1.2 mm is recommended, tip of iron should not contact the ceramic body directly, and the temperature of iron should be set to not more than 260°C.
- (3) For bigger chips such as 1210 and 1812, etc. wave soldering and hand soldering are no recommended.
- (4) Refer IPC/JEDEC J-STD-020D Method recommended soldering profiles :
Reflow not sooner than 15 minutes and not longer than 4 hrs after removal from the temperature/humidity chamber, subject the sample to 3 cycle of the appropriate reflow conditions as defined as blow Table description.
- (5) Lead-free : Soldering temperature = 235 to 260°C, depending on product.
- (6) Maximum temperature = Minimum temperature (235°C)+ ΔT + Tolerance for oven process and measurement (5 ~ 7°C)
- (7) Time at peak temperature = 10sec, Dwell above 217°C = 90sec, Ramping rate = 3°C/sec(heating) and 6 °C/sec (heating).

COOLING

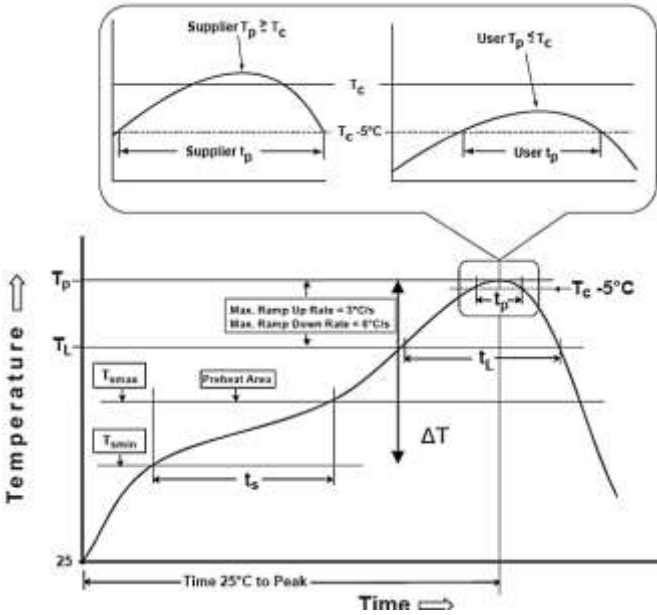
After soldering, cool the chips and the substrate gradually to room temperature. Natural cooling in air is recommended to minimize stress in the solder joint. A cooling rate not exceeding 4°C per second should be used when forced cooling is necessary.

CLEANING

All flux residues must be removed by using suitable electronic-grade vapor-cleaning solvents to eliminate contamination that could cause electrolytic surface corrosion. Good results can be obtained by using ultrasonic cleaning of the solvent. The choice of the proper system is depends upon many factors such as component mix, flux, and solder paste and assembly method. The ability of the cleaning system to remove flux residues and contamination from under the chips is very important.

MULTILAYER CERAMIC CHIP CAPACITORS 1206 SERIES

RECOMMENDED PROFILE CONDITIONS



Chip Size	ΔT
0603, 0805, 1206	100 °C
1210, 1812	50 °C

Soldering	Solder Temp.(Tc)	Soldering Time (tp)
Reflow	235 – 260 °C	< 15 sec.
Wave	230 – 260 °C	< 5 sec.

Profile Feature		Pb-Free Assembly
Preheat /Soak	Temperature Min.(T _{smin})	150°C
	Temperature Max.(T _{smax})	200°C
	Time(t _s) from (T _{smin} ~T _{smax})	60 to 120 seconds
Ramp-up rate(T _L to T _p)		3 °C/second max.
Liquidous temperature(T _L)		217°C
Time(t _L) maintained above T _L		60 to 150 seconds
Peak package body temperature(T _p)		For user T _p must not exceed the Classification temp 260°C For suppliers T _p must equal or exceed the Classification temp 260°C
Time(T _p)* within 5 of the specified °C classification temperature(T _c)		30* second
Ramp-down rate (T _p to T _L)		6 /second max.
Time 25 to peak temperature 260 °C °C		8 minutes max.

Note: For example, T_c is 260°C and time t_p is 15sec. for user: The peak temperature must not exceed 260°C. The time above 255°C must not exceed 15 seconds.

MULTILAYER CERAMIC CHIP CAPACITORS 1206 SERIES
PACKAGING STYLE AND QUANTITY

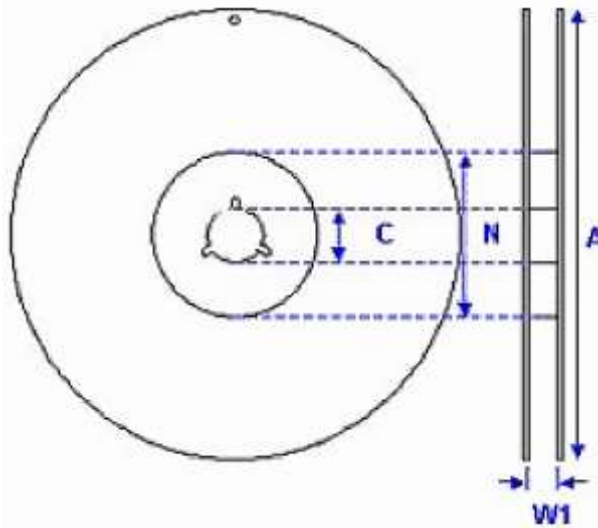
Size	Thickness (Symbol)		Paper Tape		Plastic Tape	
			7" Reel	13" Reel	7" Reel	13" Reel
0603 (1608)	0.50±0.10	N	4,000			
	0.80±0.07	S	4,000	15,000		
	0.80+0.15/-0.10	X	4,000	15,000		
0805 (2012)	0.50±0.10	N	4,000	15,000		
	0.60±0.10	A	4,000	15,000		
	0.85±0.15	B	4,000	15,000		
	0.85±0.10	T	4,000	15,000		
	1.25±0.15	C			3,000	10,000
1206 (3216)	0.85±0.15	B	4,000	15,000		
	0.85±0.10	T	4,000	15,000		
	0.95±0.10	I			3,000	10,000
	1.15±0.15	J			3,000	10,000
	1.25±0.15	C			3,000	10,000
	1.60±0.15	D			2,000	10,000
	1.60+0.30/-0.10	P			2,000	9,000
1210 (3225)	0.85±0.10	T			3,000	10,000
	0.95±0.10	I			3,000	10,000
	1.25±0.15	C			3,000	10,000
	1.60±0.15	D			2,000	
	2.00±0.20	K			1,000	6,000
	2.50±0.30	M			1,000	6,000

MULTILAYER CERAMIC CHIP CAPACITORS 1206 SERIES

PACKAGING STYLE AND QUANTITY

Size	Thickness (Symbol) (mm)		Paper Tape		Plastic Tape	
			Pcs/7" Reel	pcs/13" Reel	Pcs/7" Reel	Pcs/13" Reel
1812 (4532)	1.25±0.15	C			1,000	5,000
	1.60±0.15	D			1,000	
	2.00±0.20	K			1,000	
	2.50±0.30	M			500	3,000
	2.80±0.30	U			500	

REEL DIMENSION (Unit: mm)

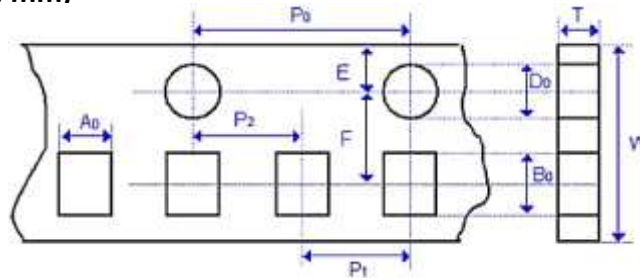


Size Code	0603, 0805, 1206, 1210			1812
Reel Size	7"	10"	13"	7"
C	13.0+0.5/-0.2	13.0+0.5/-0.2	13.0+0.5/-0.2	13.0+0.5/-0.2
W 1	8.4+1.5/0	8.4+1.5/-0	8.4+1.5/-0	12.4+2.0/-0
A	178.0±0.10	250.0±1.0	330.0±1.0	178.0±0.10
N	60.0+1.0/-0	100.0±1.0	100±1.0	60.0+1.0/-0

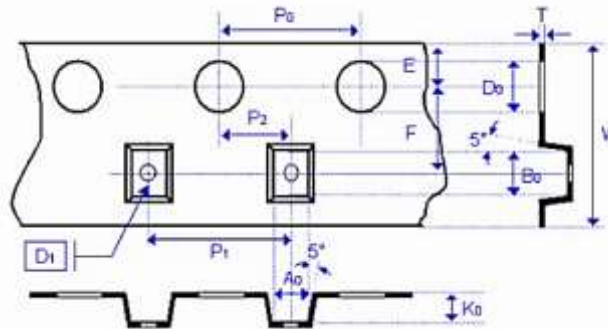
MULTILAYER CERAMIC CHIP CAPACITORS 1206 SERIES

TAPE DIMENSION (Unit: mm)

Paper Tape



Plastic Tape



Size	0603	0805		
Thickness	S, B, X	A, H	B, X	C
A0	1.05 +/-0.30	1.5+/-0.20	1.5 +/-0.20	< 1.80
B0	1.80 +/-0.30	2.30 +/-0.20	2.30 +/-0.20	< 2.70
T	≤1.20	≤1.15	≤1.20	0.23 +/-0.1
K0	-	-	-	< 2.50
W	8.00 +/-0.30	8.00 +/-0.30	8.00 +/-0.30	8.00 +/-0.30
P0	4.00 +/-0.10	4.00 +/-0.10	4.00 +/-0.10	4.00 +/-0.10
10xP0	40.0 +/-0.20	40.0 +/-0.20	40.0 +/-0.20	40.0 +/-0.20
P1	4.00 +/-0.10	4.00 +/-0.10	4.00 +/-0.10	4.00 +/-0.10
P2	2.00 +/-0.05	2.00 +/-0.05	2.00 +/-0.05	2.00 +/-0.05
D0	1.50 +0.1/-0	1.50 +0.1/-0	1.50 +0.1/-0	1.50 +0.1/-0
D1	-	-	-	1.00 +/-0.10
E	1.75 +/-0.10	1.75 +/-0.10	1.75 +/-0.10	1.75 +/-0.10
F	3.50 +/-0.05	3.50 +/-0.05	3.50 +/-0.05	3.50 +/-0.05

MULTILAYER CERAMIC CHIP CAPACITORS 1206 SERIES
TAPE DIMENSION (Unit: mm)

Size	1206			1210		
	B	I, C,	D,	B	I, C, D, K	M
Thickness						
A0	1.90 +/-0.50	< 2.00	< 2.30	< 3.05	< 3.05	< 3.20
B0	3.50 +/-0.50	< 3.70	< 4.00	< 3.80	< 3.80	< 4.00
T	≤1.20	0.23 +/-0.1	0.23 +/-0.1	0.23 +/-0.1	0.23 +/-0.1	0.23 +/-0.1
K0	-	< 2.50	< 2.50	< 1.50	< 2.50	< 3.20
W	8.00 +/-0.30	8.00 +/-0.30	8.00 +/-0.30	8.00 +/-0.30	8.00 +/-0.30	8.00 +/-0.30
P0	4.00 +/-0.10	4.00 +/-0.10	4.00 +/-0.10	4.00 +/-0.10	4.00 +/-0.10	4.00 +/-0.10
10xP0	40.0 +/-0.20	40.0 +/-0.20	40.0 +/-0.20	40.0 +/-0.20	40.0 +/-0.20	40.0 +/-0.20
P1	4.00 +/-0.10	4.00 +/-0.10	4.00 +/-0.10	4.00 +/-0.10	4.00 +/-0.10	4.00 +/-0.10
P2	2.00 +/-0.05	2.00 +/-0.05	2.00 +/-0.05	2.00 +/-0.05	2.00 +/-0.05	2.00 +/-0.05
D0	1.50 +0.1/-0	1.50 +0.1/-0	1.50 +0.1/-0	1.50 +0.1/-0	1.50 +0.1/-0	1.50 +0.1/-0
D1	-	1.00 +/-0.10	1.00 +/-0.10	1.00 +/-0.10	1.00 +/-0.10	1.00 +/-0.10
E	1.75 +/-0.10	1.75 +/-0.10	1.75 +/-0.10	1.75 +/-0.10	1.75 +/-0.10	1.75 +/-0.10
F	3.50 +/-0.05	3.50 +/-0.05	3.50 +/-0.05	3.50 +/-0.05	3.50 +/-0.05	3.50 +/-0.05

Size	1812	
	C, D, K	M
Thickness		
A0	< 3.90	< 3.90
B0	< 5.30	< 5.30
T	0.25 +/-0.1	0.25 +/-0.1
K0	< 2.50	< 3.50
W	12.00 +/-0.30	12.00 +/-0.30
P0	4.00 +/-0.10	4.00 +/-0.10
10xP0	40.0 +/-0.20	40.0 +/-0.20
P1	8.00 +/-0.10	8.00 +/-0.10
P2	2.00 +/-0.10	2.00 +/-0.10
D0	1.50 +0.1/-0	1.50 +0.1/-0
D1	1.50 +/-0.10	1.50 +/-0.10
E	1.75 +/-0.10	1.75 +/-0.10
F	5.50 +/-0.10	5.50 +/-0.10

MULTILAYER CERAMIC CHIP CAPACITORS 1206 SERIES

STORAGE AND HANDLING CONDITIONS

- (1) To store products at 5 to 40°C ambient temperature and 20 to 70% related humidity conditions.
- (2) No harmful gases containing sulfuric acid, ammonia, hydrogen sulfide or chlorine. Packaging should not be opened until the capacitors are required for use. If opened, the pack should be re-sealed as soon as is practicable. Taped product should be stored out of direct sunlight, which might promote deterioration in tape or adhesion performance. The capacitors should be used within one year and checked the solderability before use.
- (3) Don't open the tape until the parts are to be used, use the chips within 3 months after the tape is opened.
- (4) For product of high dielectric constant (Class2 & 3, characteristics B/W & Y), the Electro static capacity changes with the passage of time due to the inherent characteristics of ceramic dielectric materials. The changed capacity reverts to nominal at the temperature it reaches during the soldering process.
- (5) HANDLING : Chip capacitors are dense, hard, brittle, and abrasive materials. They are liable to suffer mechanical damage, in the form of cracks or chips. Chip Capacitors should be handled with care to avoid contamination or damage. To use vacuum or plastic tweezers to pick up or plastic tweezers is recommended for manual placement. Tape and reeled packages are suitable for automatic pick and placement machine.

CAUTIONS

- (1) The corrosive gas reacts on the terminal electrodes of capacitors, and results in the poor solder ability. Do not store the capacitors in the ambience of corrosive gas (e.g., hydrogen sulfide, sulfur dioxide, chlorine, ammonia gas etc.)
- (2) In corrosive atmosphere, solder ability might be degraded, and silver migration might occur to cause low reliability.
- (3) Due to the dewing by rapid humidity change, or the photochemical change of the terminal electrode by direct sun light, the solder ability and electrical performance may deteriorate. Do not store capacitors under direct sunlight or dewing condition. To store products on the shelf and avoid exposure to moisture.

DISCLAIMER

NextGen Component, Inc. reserves the right to make changes to the product(s) and or information contained herein without notice. No liability is assumed as a result of their use or application. No rights under any patent accompany the sale of any such product(s) or information